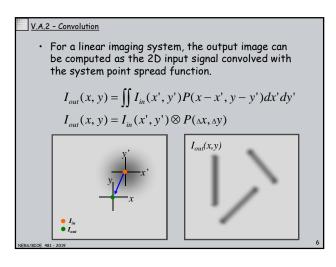


V.A.1 - Linear System Properties

• Linearity

- For many inputs to a system, the output corresponds to a the sum of the outputs that would occur if each input was separately applied.
- Multiplication of the input by a constant multiplies the output by the same constant.
- Spatial invariance
 - The image resulting from a point input is the same for all input positions. For some systems, the response may be large scale invariant with respect to the response of adjacent detector elements, but small scale variant with respect to input positions within one detector element.
- <u>Isotropic response</u>
 - Imaging systems for which the point response function is the same in all directions can be described by one dimensional response functions.

See Rossman, Radiology1969



V.A.2 - Convolution

A special case of convolution is the autocorrelation function, ACF, which is the convolution of a function with the same function.

$$ACF(\chi,\eta) = \iint f(x,y)f(x+\chi,y+\eta)dxdy$$

We will see shortly where the ACF is useful for describing noise based on the deviation of the signal from the mean, $\Delta S(x,y)$. In this case, ACF(0,0) is just σ_S^{2} .

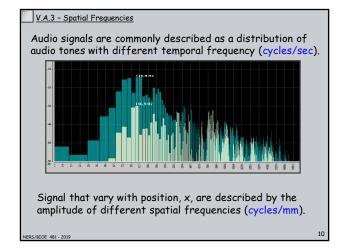
V.A.3 - Fourier Analysis

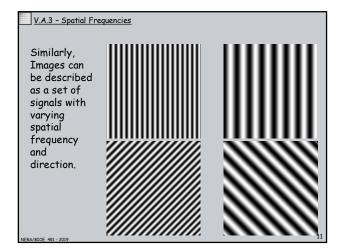
- The Fourier transform can be used to evaluate the frequency composition of a signal. For imaging systems the signal is often a function of a two spatial variables. For simplicity, consider only the variation of the image signal in one dimension, S(x).
- The Fourier transform operates on S(x) to produce a function which varies with spatial frequency, $S(\omega_x)$.
- When the variable x has units of mm the variable ω_x will have units of cycles/mm.
- The Fourier transform may be mathematically expressed as an integral transformation involving an imaginary trigonometric operator.

$$\mathsf{S}(\omega_x) = \int_{-\infty}^{\infty} S(x) e^{-i2\pi x \omega_x} dx$$

$$e^{ix} = \cos(x) + i\sin(x)$$

V.A.3 - Fourier Analysis Symmetric signals If the signal is symmetric about x=0, then the Fourier transform is real. $S(\omega_x) = \int S(x) \cos(2\pi x \omega_x) dx$ For example, if S(x) is a unit impulse function at x=0, then the tranform is simply $S(\omega_x) = 1$ for all values of ω_x . Inverse Transform A similar inverse Fourier transform $S(x) = \int \mathbf{S}(\omega_x) e^{i2\pi x \omega_x} d\omega_x$ operates on a frequency domain function to produce the corresponding spatial domain function. If $S(w_x)$ is obtained from the Fourier transform of S(x), then the inverse Fourier transform of $S(w_x)$ results in the original function S(x). S(x) and $S(w_{\rm x})$ are thus often referred to as the <u>spatial domain</u> and <u>frequency domain</u> representations of the same signal.



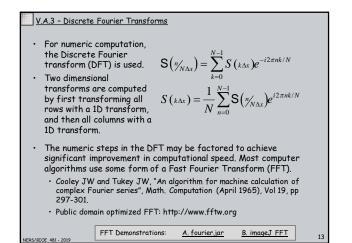


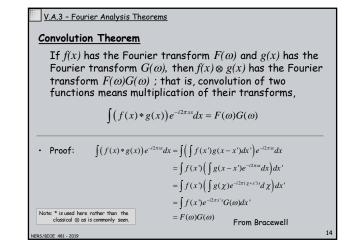
V.A.3 - Fourier Analysis

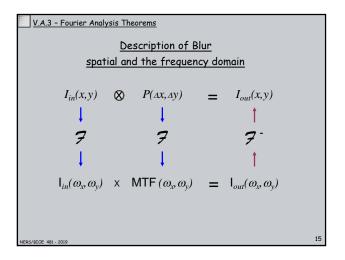
• The two dimensional Fourier transform can be used to evaluate the spatial frequency composition of an image. The inverse 2D transform is defined similarly.

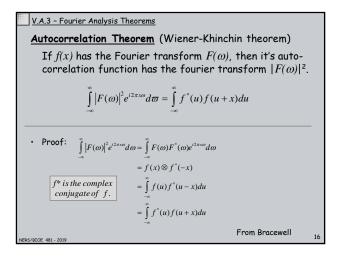
$$S(\omega_x, \omega_y) = \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} S(x, y) e^{-i2\pi (x\omega_x + y\omega_y)} dxdy$$

 S(w_x, w_x) for a particular value of (w_x, w_x), corresponds to a 2D image with directionally oriented sinusoidal signal variation.

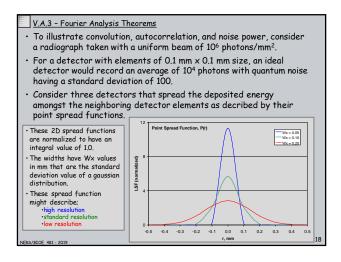


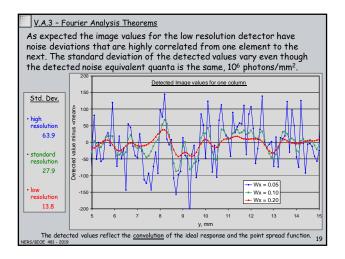


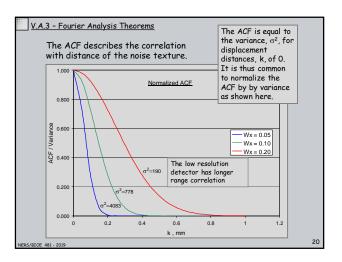


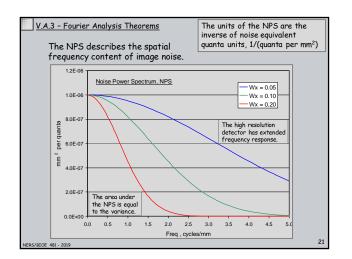


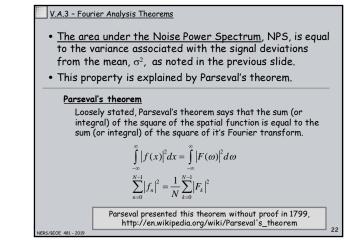
$$\begin{split} \underbrace{ \bigvee A.3 - \text{Fourier Analysis Theorems} } \\ As a special case of the autocorrelation theorem, the autocorrelation function of signal deviations is the Fourier transform of its noise power spectrum. \\ ACF(\chi,\eta) = \iint NPS(\omega_x, \omega_y)e^{+2\pi i(\chi\omega_x + \eta\omega_y)}d\omega_x d\omega_y \\ NPS(\omega_x, \omega_y) = \iint ACF(\chi, \eta)e^{-2\pi i(\chi\omega_x + \eta\omega_y)}d\chi d\eta \\ \text{Where the NPS is the Fourier transform of signal deviations from the mean, } \Delta S, \\ NPS(\omega_x, \omega_y) = \left\langle \frac{1}{2X2Y} \middle| \int_{-x}^{x} \int_{-y}^{y} \Delta S(x, y)e^{-2\pi i(x\omega_x + y\omega_y)}dx dy \middle|^2 \right\rangle \end{split}$$

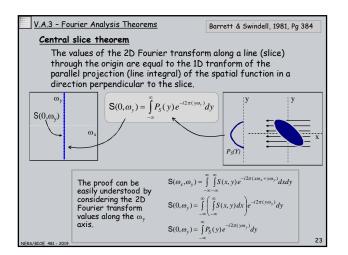


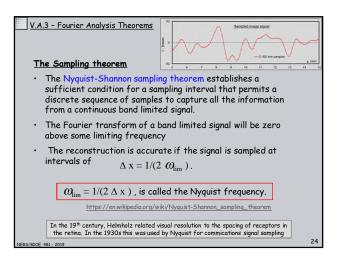


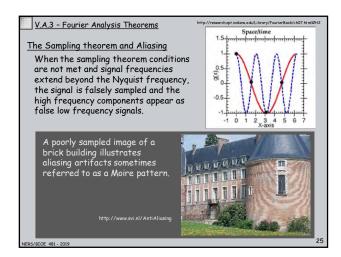


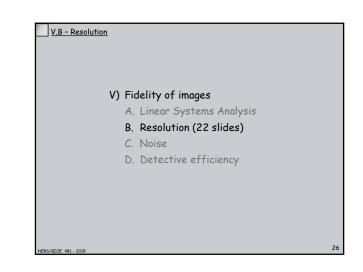


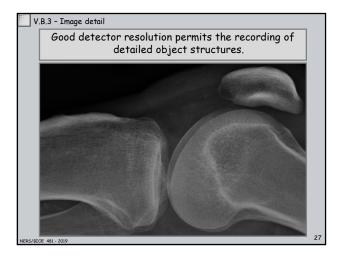


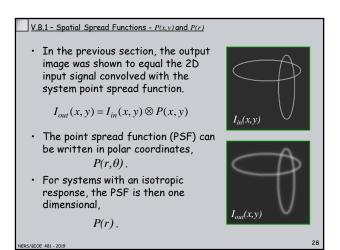






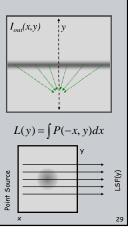


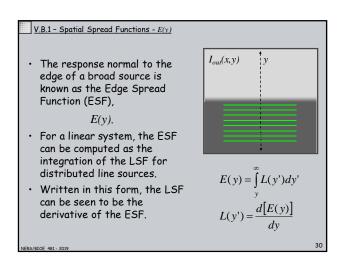


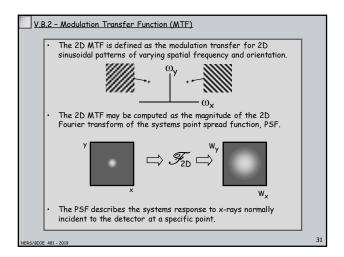


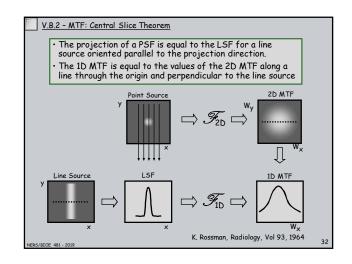
V.B.1 - Spatial Spread Functions - L(y)

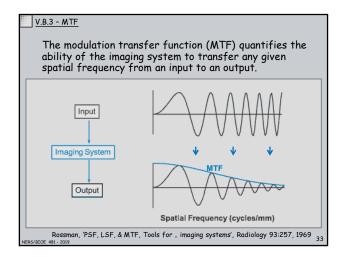
- The response to a line source is known as the Line Spread Function (LSF), L(y), which is the response normal to the line.
- For a linear system, the LSF can be computed as the integration of the PSF for point sources distributed in a line.
- Written in this form, the LSF can be seen to be the line integral of the PSF in the x direction for all values of y.
- This is often referred to as the projection of the PSF.

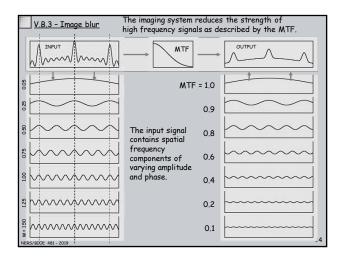


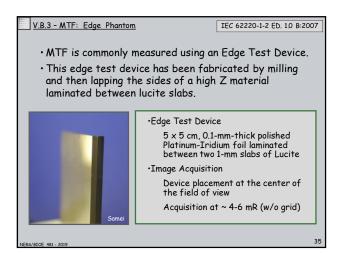


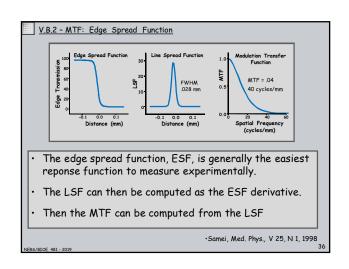


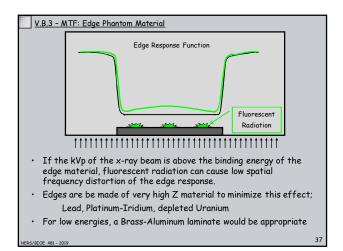


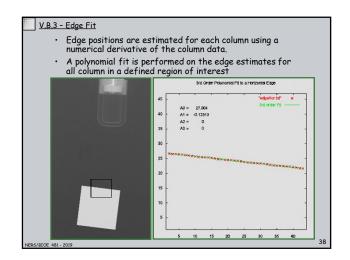


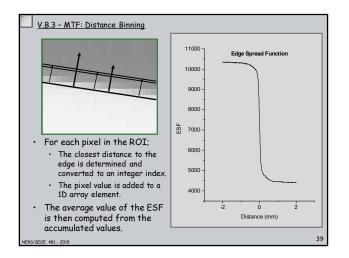


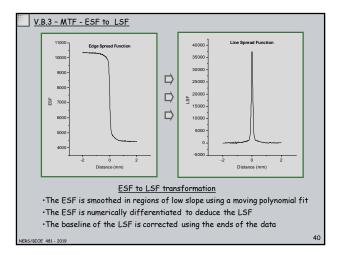


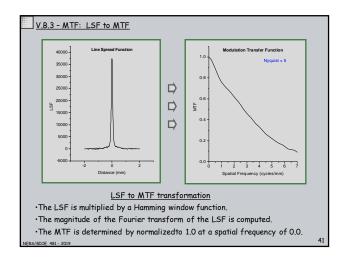


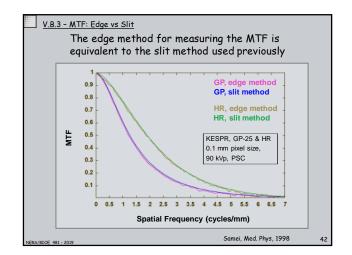


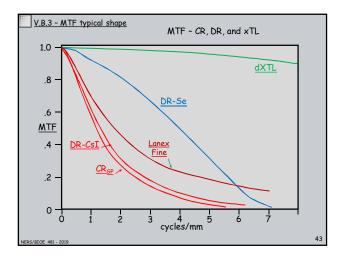


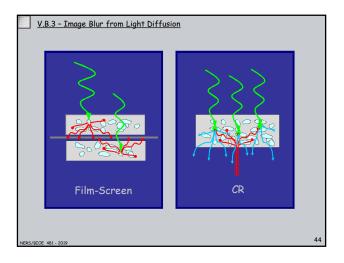


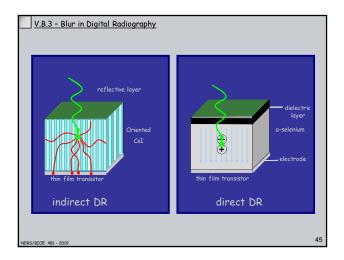


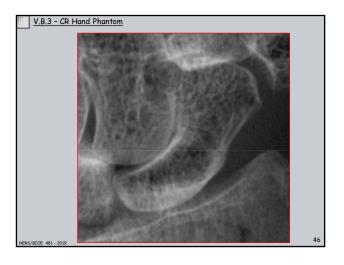


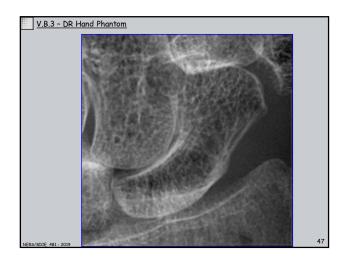


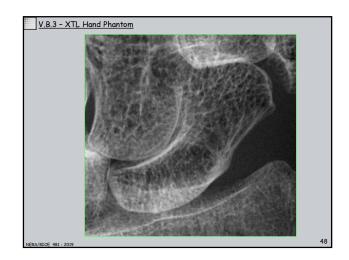


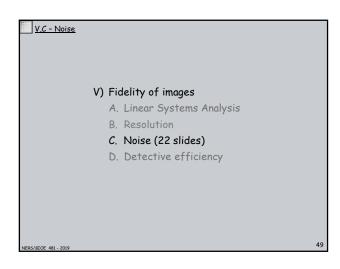


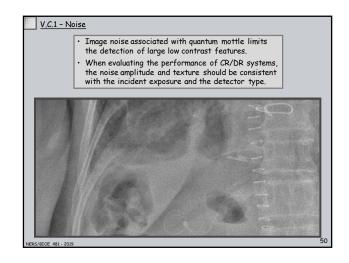


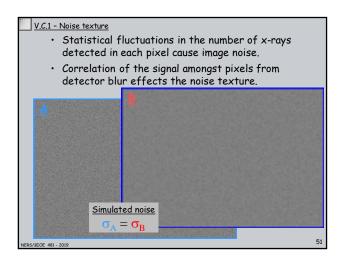


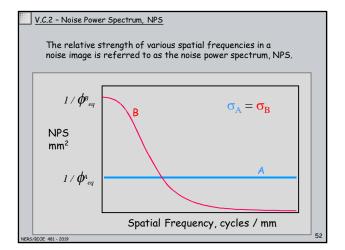


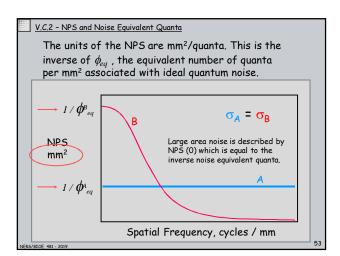


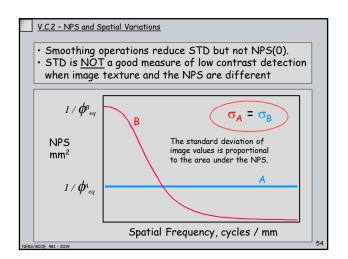


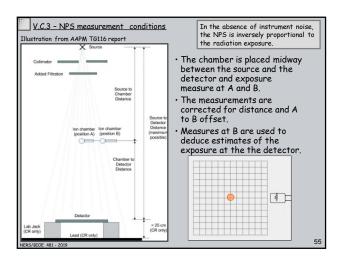




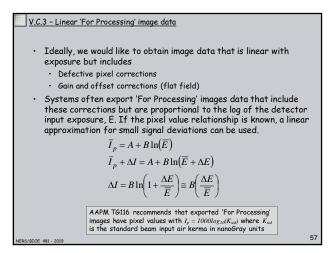


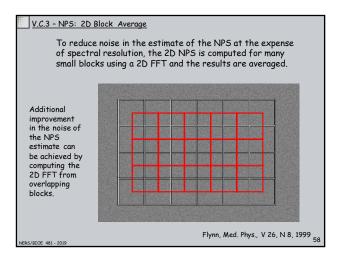


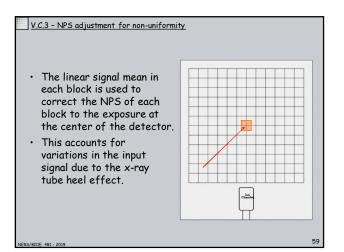




IEC and AAPM have published documents on Exposure Indices that include a standard beam condition similar to RQA5.								
	HVL	kV	Adde	d Cu	Added Al			
IEC 62494	6.8 +/3	70 +/- 4	0.5	mm	2 mm			
AAPM TG116	6.8 +/25	70 +/- 4	0.5	mm	0-4 mm			
oublished work h	as	Added Al	HVL mm Al	Nomina kVp	· / F · · · ·			
ised IEC RQA	RQA5	Al 21 mm	mm Al 7.1	kVp 70	kVp 72-77			
ised IEC RQA	DO 15	Al	mm Al	kVp	kVp			
ised IEC RQA beam conditions.	RQA5	Al 21 mm 40 mm	mm Al 7.1 11.5	kVp 70 120	kVp 72-77 120-124			
used IEC RQA beam conditions.	RQA5 RQA9	Al 21 mm 40 mm	mm Al 7.1 11.5	kVp 70 120	kVp 72-77 120-124			
used IEC RQA beam conditions. It is now co	RQA5 RQA9	Al 21 mm 40 mm asure NPS o	mm Al 7.1 11.5	kVp 70 120	kVp 72-77 120-124 sure values			







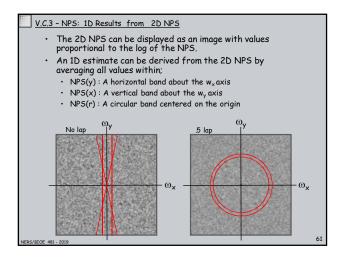
V.C.3 - FFT estimate of the NPS

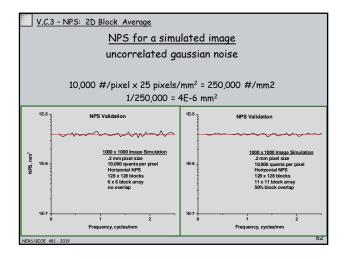
OE 481 - 2019

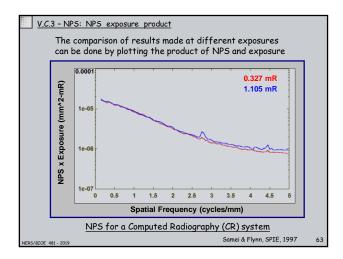
The estimate of the NPS for each block is done using a Fast Fourier Transform, FFT, as described in Flynn1999.

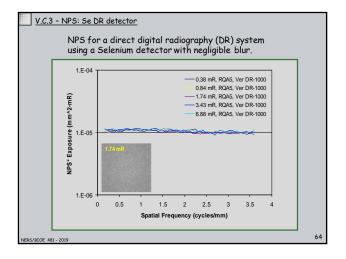
- A bi-quadratic surface is fit to the block values to obtain the mean value and low frequency trend (see Zhou, MedPhys 2011)
- 2. Relative noise deviations are computed based on whether the data is linear or logarithmic.
- 3. Values are adjusted for image pixel area.
- 4. Block values are modified by a spectral window function (Hamming).
- 5. The NPS is computed as the magnitude squared of the Fourier transform.

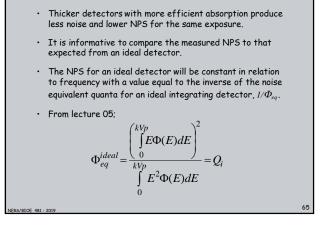
Flynn, Med. Phys., V 26, N 8, 1999 60



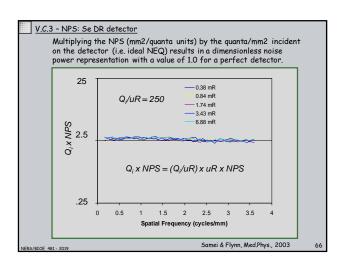


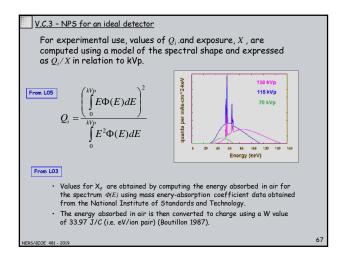


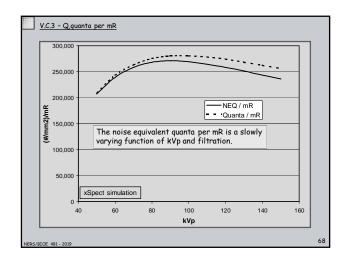




V.C.3 - NPS for an ideal detector

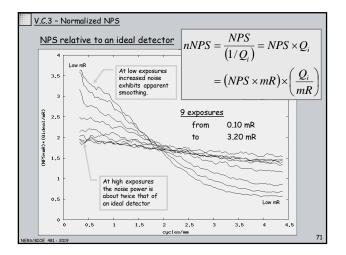


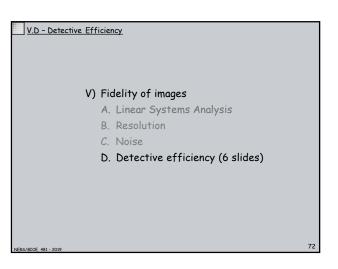


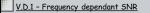


Reference	Beam Conditions	Added Filtration	Method	Q, #/mm2 per µR	Q, #/mm2 per nG
Dobbins MedPhys 1992	70 kVp -	0.5 mm Cu	Provided by Manf.	270	[30.8]
Kengylelics MedPhys 1998	75 kVp -	1.5 mm Cu	Photon fluence	[310]	35.4
Stierstorfer MedPhys 1999	70 kVp 7.1 mm HVL	21 mm Al	NEQ (energy intgr. detector)	[258]	29.4
Flynn & Samei MedPhys 1999	70 kVp 6.3 mm HVL	19 mm Al	NEQ (energy intgr. detector)	262	[29.9]
Samei & Flynn MedPhys 2002	70 kVp -	19 mm Al	NEQ (energy intgr. detector, HVL adj.)	246-249	[28.1-28.4]
Granfors MedPhys 2003	75 kVp 7.0 mm HVL	20 mm Al	Photon fluence	[261]	29.8
IEC 62220-1 1ª ed. 2003	77 kVp 7.1 mm HVL	21 mm Al (RQA 5)	Photon fluence	[264]	30.2
Samei & Flynn MedPhys 2003	74-78 kVp 7.1 mm HVL	21 mm Al	NEQ (energy intgr. detector, HVL adj.)	256-259	[29.2-29.6]
Samei MedPhys 2003	70 kVp 6.4,6.5 mmHVL	19 mm Al	NEQ (energy intgr. detector, HVL adj.)	255-258	[29.1-29.5]
Siewerdsen MedPhys 2005	60, 80 kVp	4 mm Al 0.6 mm Cu	Photon fluence	259, 283	[29.6,32.3]

Q per	Q per µR for TG116/IEC beam conditions <u>Noise equivalent quanta computed from a spectral model</u> , • Qi/uR E integr: Ideal energy integrating detector • Qi/uR Fluence: Ideal counting detector • Qi/uR dDR: Direct DR detector (.5 mm Se)							
kV	Added Cu Filtration	Added Al Filtration	HVL	Qi/µR E integr.	Qi∕µR Fluence	Qd∕µR dDR		
70	0.5 mm	0.0 mm	6.6	251	(258)	145		
70	0.5 mm	2.0 mm	6.8	255	(262)	144		
70	0.5 mm	4.0 mm	7.0	258	(265)	144		
ר • ד ד מ	 Within the range of added filtration and HVL acceptable for AAPM EI beam conditions, the Qi per mR varies by about +/- 1.5% The Qi per mR for an ideal counting detector is about 2.7% higher that that for an ideal energy integrating detector. The noise equivalent quanta, and therefor NPS(0) for a DR detector varies little with beam conditions. 							







V.D.2 - DQE: Detective Quantum Efficiency

 $DQE(\omega) = SNR^{2}_{meas}(\omega) / SNR^{2}_{ideal}$

 $DQE(\omega) = \frac{\left(MTF^{2}(\omega) / NPS(\omega)\right)}{\left(MTF^{2}(\omega) / NPS(\omega)\right)}$

 $DQE(\omega) = \frac{MTF^{2}(\omega)}{Q_{i} \times NPS(\omega)} = \frac{MTF^{2}(\omega)}{nNPS(\omega)}$

 Q_i

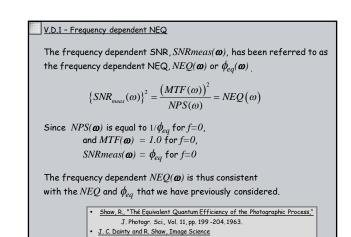
- Since the NPS is normalized to the inverse of $\pmb{\phi}_{eq}$ at zero frequency,
- and ϕ_{eq} is understood to be the square of the signal to noise ratio,
- the $NPS(\mathbf{\omega})$ can be understood as the square of the frequency dependant noise relative to the overall signal,

$$NPS(\omega) = \left(\frac{\sigma(\omega)}{S}\right)^2$$

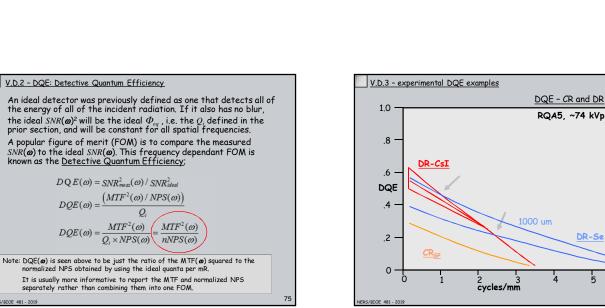
Since the frequency dependant signal is $S\ast MTF(\pmb{\omega})$, the frequency dependant signal to noise ratio can be defined as,

$$\left\{SNR(\omega)\right\}^{2} = \frac{\left(S \times MTF(\omega)\right)^{2}}{\left(\sigma(\omega)\right)^{2}} = \frac{\left(MTF(\omega)\right)^{2}}{NPS(\omega)}$$

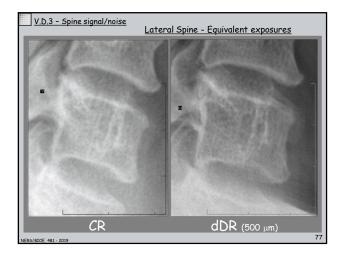
Note: as written, this is the actual frequency dependant SNR that can be computed from experimental measures of the MTF and NPS

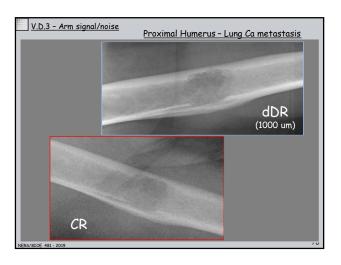


Academic Press, London, 1974. (a) Ch. 5. (b) Ch. 8.









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